Issue Classification



ORIGINAL

Application/Control No.	

Applicant(s)/Patent Under Reexamination
ITO ET AL.

Examiner ARLEEN M VAZQUEZ Art Unit

INTERNATIONAL CLASSIFICATION

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☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ R.1.47																			
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Examiner.Art Unit 2829	11/12/2008	Total Claims Allowed:			
		19			
(Assistant Examiner)	(Date)				
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Supervisory Patent Examiner.Art Unit 2829	11/12/2008	O.G. Print Claim(s)	O.G. Print Figure		
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(Primary Examiner)	(Date)		4		